## Scaling and Renormalization in Fault-Tolerant Quantum Computers

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### **Fault-Tolerant Quantum Computation**

- Big Question: is it possible to run an arbitrarily long quantum computation in the presence of errors?
- <u>First Crack:</u> Shor (1996) yes, provided that *error rate is polylogarithmically small in circuit size*; a physically unreasonable assumption!
- <u>State-of-the-Art:</u> Kitaev (1997), Knill, Laflamme, and Zurek (1998), Preskill (1998), Aharonov and Ben-Or (1999) - yes, provided that *error rate is smaller than some threshold value*  $\eta_c$ ; requires polylogarithmic complexity overhead

### The Scoop on Aharonov and Ben-Or

Rigorous proofs of the "threshold theorem" for:

- local stochastic noise
- noise with exponentially decaying correlations
- general noise

(including computers with qubits arranged on the hypercubic lattice  $\mathbb{Z}^d$ , d=1,2,..., with gates applied to nearest neighbors only)

<u>Key technique:</u> hierarchical simulations using concatenated quantum error-correcting codes

### How to Interpret the Proof of Aharonov and Ben-Or

- Local stochastic noise in the computer C = defects (disorder) on a suitably constructed graph  $\Gamma_C$
- Concatenation = "renormalization" of  $\Gamma_C$ ; start with a subthreshold system, iterate the renormalization map to push the system away from the threshold and toward the trivial  $(\eta \rightarrow 0)$  behavior
- Threshold error rate  $\eta_c$  = nontrivial fixed point of the renormalization map

### Quantum Circuits, Interaction Graphs, and Error Locations

Given a quantum circuit *C*, we construct the interaction graph  $\Gamma_C$ 



### Concatenated Codes and Hierarchical Simulation

 <u>Concatenated code</u>: encode each qubit in a block of *m* qubits, encode each of those in a block of *m* qubits, …

*r* levels of concatenation  $\rightarrow$  each qubit is encoded in *m*<sup>*r*</sup> qubits

• <u>Hierarchical simulation</u>: compute directly on encoded states; start with circuit  $C_0$ , replace each gate with a fault-tolerant procedure (including error correction) to get  $C_1 = M(C_0)$ ; continue *r* times to get  $C_r = M^r(C_0)$ 

### **Quantum Computation Codes**

### Ingredients:

- quantum error-correcting code 1-to-*m*, can correct up to *d* errors
- spread s of the code: one error anywhere during a procedure will result in at most s single-qubit errors at the end of the procedure; demand s≤d
- all operations (encoding, decoding, computation) are performed using gates from some universal set

# Local Stochastic Noise and Bernoulli Site Percolation on $\Gamma_C$

Local stochastic noise: each vertex of  $\Gamma_C$  is affected by an error with probability  $\eta$  and left intact with probability  $1-\eta$ , independently of all other vertices; thus all vertices are statistically equivalent

Key feature:

- percolation threshold η<sub>\*</sub>: no infinite connected cluster a.s. for η < η<sub>\*</sub>, infinite connected cluster a.s. for η > η<sub>\*</sub>
- mean cluster size is finite for  $\eta < \eta_*$ ,

### Estimating the Threshold: Renormalization Argument

- One level of concatenation:  $C_0 \rightarrow C_1, \Gamma_0 \rightarrow \Gamma_1$
- Renormalize  $\Gamma_1$  by replacing all of the vertices corresponding to a procedure with a single vertex, draw edges appropriately - the resulting graph  $R(\Gamma_1)$  should be isomorphic to  $\Gamma_0$  (from local self-similarity)
- New site percolation process on  $R(\Gamma_1)$ : a vertex is occupied if k+1 or more errors occurred in the corresponding procedure in  $\Gamma_1$ , where  $k = \lfloor d/s \rfloor$ .

## Estimating the Threshold: Renormalization Argument (cont'd)

• The renormalized site occupation probability:

$$R(\eta) \leq \sum_{l=k+1}^{A} \binom{A}{l} \eta^{l} (1-\eta)^{A-l} \leq 2^{A} \eta^{k+1}$$

*A* = maximum number of locations in a procedure

- The effective error rate goes down, i.e.,  $R(\eta) < \eta$ , for  $\eta$  satisfying the threshold condition  $\eta < \eta_c = 2^{-A/k}$  (expect it to be much smaller than the percolation threshold  $\eta_*$ )
- Iterate r times to get  $R^r(\eta) \le 2^{-A/k} (2^{A/k} \eta)^{(k+1)^r}$ ; for  $\eta < \eta_c$  we have  $R^r(\eta) < R^{r-1}(\eta) < ... < R(\eta) < \eta$

## Estimating the Threshold: Renormalization Argument (cont'd)

### What is the required number of concatenation levels?

- *N* = number of locations in the original circuit *C*<sub>0</sub> (including identity gates)
- Given some  $\varepsilon > 0$ , we want the effective error rate per procedure in  $C_r$  to be smaller than  $\varepsilon / N$ , so that the total error is less than  $\varepsilon$

The required number of concatenation levels is polylogarithmic in N:  $r = O(polylog(N/\varepsilon))$ 

### Exact Value of the Threshold



## Trade-Off between Complexity Overhead and Threshold Error Rate

• From general arguments in percolation theory [Chayes, Chayes, Fisher, and Spencer (1986)]:

$$\frac{R(\eta)(1-R(\eta))}{\eta(1-\eta)} \le R'(\eta) \le \sqrt{\frac{A}{\eta(1-\eta)}}$$

• The rate at which the effective error rate goes down with concatenation in a subthreshold computer is controlled by  $\lambda = R'(\eta_c)$ 

Key inequality: 
$$1 < \lambda \leq \sqrt{\frac{A}{\eta_c(1-\eta_c)}}$$

### Trade-Off ... (cont'd)

For *r* concatenation levels to suffice, we must have  $\lambda = 2^{K/r}$ , where *K* is some constant Then

$$2^{K/r} \leq \sqrt{\frac{A}{\eta_c(1-\eta_c)}}$$

We get the *trade-off inequality*:

$$\eta_c(1-\eta_c) \le A2^{-2K/r}$$

### Summary

- The idea behind the proof of the "threshold theorem" for fault-tolerant quantum computation can be seen as a renormalization argument for a suitably defined site percolation process
- In general, subthreshold quantum computers will be well into the subcritical phase of the percolation process
- There is a trade-off between the threshold error rate and the complexity overhead needed for the fault-tolerant circuit